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9 PHOTOGRAPHS OF TEST SETUP

Test model No.: iSmartEV DP750



Radiated spurious emission Test Setup-1(Below 1GHz)

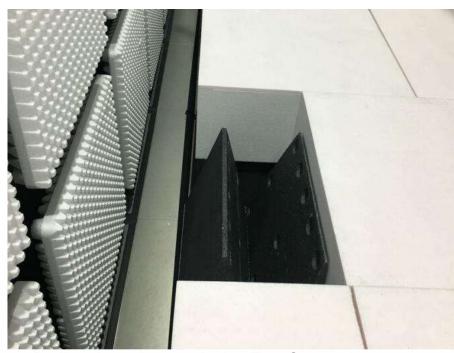




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Radiated spurious emission Test Setup-3(Above 1GHz) There are absorbing materials under the ground.



Conducted Emissions Test Setup







